

Krishna Kalidindi

From: Mihaylov, Michael [mmihaylov@fulbright.com]
Sent: Wednesday, December 19, 2001 11:20 PM
To: Lin, Qian
Cc: Carson, John
Subject: Revised Final Draft of Photo Quality Meter Patent App

Importance: High



25087384_1.DOC

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Qian: Please review the enclosed revised final draft and respond to all questions/comments in bold directly in the text in red ink. You may find it beneficial to compare and track changes with previous draft. Thank you.

Best Regards,

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